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Application/Control No.	Applicant(s)/Patent under Reexamination
09/965,166	SCHNEIDER, STEVE
Examiner	Art Unit
Nathan Wiehe	3745

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Class	Subclass	Date	Examiner
415	198.1, 199.1, 199.2, 199.3	8/30/2006	NEW
415	211.2	४।३०।०५	NEW
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
415/198.1,199.1,199.2,199.3,211.2 Ninh Nguyen	8/30/2006	NEW		
Text Search (See EAST Search Hsitory)	8/30/2006	, NEW		
Inventor Name Search	8/30/2006	NEW		
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